























Structural/Sacrifical Material Combinations Structural Material Sacrificial Material **Etchant** Poly-Si SiO₂, PSG, LTO HF, BHF Αl **Photoresist** O₂ plasma SiO₂ Poly-Si XeF2 Αl Si TMAH, XeF, Poly-SiGe Poly-Ge H2O2, hot H2O

- Must consider other layers, too, as release etchants generally have a finite E.R. on any material
- * Ex: concentrated HF (48.8 wt. %)
 - Polysilicon E.R. ~ 0
- Silicon nitride E.R. ~ 1-14 nm/min
- Wet thermal SiO₂ ~ 1.8-2.3 μm/min
 Annealed PSG ~ 3.6 μm/min
- ♦ Aluminum (Si rich) ~ 4 nm/min (much faster in other Al)

		Wet-Euch	Rates for	Microm	chining	and IC	Processing	(Å/min)					_				
The top each rate was measured by the authors with fee	A solutions, esc. Th	e center and	bottom:	raises are	the low a	nd high	esch mies i	bserved by			ers in our	lab under l	ess carefu	dly contr	ciled con	Siriona.	
ETCHANT	MATERIAL.													_	-		
SQUIPMENT	TARGET	SC Si	Poly	Poly	Wet	Dry	LTO	P50	PSG	Stoic	Leve	AV	Sput	Sput	Sput	000	Olin
CONDITIONS	MATERIAL	<100>	10	undop	Ox	Ox	undre	wat	annid	Natid	Nixid	29.51	Tung	Ti	T/W	120FR	Hed%
Concentrated HF (49%) Wet Sink Room Temperature	Silicon oxides		0		23k 16k 23k	'	>14k	۴	36k	(49	52 30 52	42 0 42	<50	r		PO	١,٠
10:1 HF Wet Sink	Silicon		7	0	230	230	340	15k	4700	11	3	2500 2500	0	Hk	<70	0	0
Room Temperature 25:1 HF Wee Sink	Silicon		0	0	97	95	150	w	1500	6	-	12k W	0		-	0	0
Room Temperature 5.1 MeD	Stition	١.		- 2	1000	1000	1200	6800	4400	,	4	1400	<20	F	1000	0	
Wet Sink Raom Temperature	oxides				900 1080				3500 4400		3 4		0.25 20				
Phosphoric Acid (85%) Housed Buth with Reflux 166°C	Silicon. mitrides		7		0.7	0.8	<1	37	24 9 24	28 28 42	19 19 42	9600				550	390
Silteon Eichert (126 HNO ₃ : 60 H ₂ O: 5 NH ₂ F) Wet Sink Rose Temperature	Stilcon	1500	3100 1200 6000	1000	87	¥	110	4000	1700	2	. 3	4000	130	3000		0	0
KOH (1 KOH : 2 H _a O by weight) Hexad Staved Bath 80°C	<1005 Silicen	14k	>10k	F	77 41 77		94	w	380	0	0	k	0			F	F
Aluminum Exhant Type A (16 H ₂ PO _e : 1 HNO ₃ : 1 HAc: 2 H ₂ O) Hound Buth 50°C	Alamaium		<10	9	0	۰	0		<10	0	2	5600 2600 5600		0		0	0
Transium Elechant (20 H ₂ O : 1 H ₂ O ₂ : 1 HF) Wet Steink Room Temperature	Trunium		12		120	w	•	w	2100		4	w	0	8800		0	0
Room Emperaturi H ₂ O ₂ (ONE) Wet State Room Temperature	Tangaten	-	0	0	0	0	0	0	٥	0		-20	190 190 1000	0	60 60 150	a	۰
Prents (-50 H,SO _a : 1 H ₂ O _a) Hosted Both	Cleaning off metals and		0	0	0	0	0	-	0	0		1800		2400		P	,
130°C Acrone Wer Sink	Organics Photomulat	-	0		0	0	0		0	0	0	0	-	0		34%	>398
Wet Sink Room Temperature																	

Film Etch Chemistries • For some popular films: Wet etchant Dry etchant Material Etch rate Etch rate [nm/min] [nm/min] Polysilicon HNO3:H2O: 120-600 SF₆ + He 170-920 NH₄F SF₆ Silicon H₃PO₄ 150-250 nitride 50-150 Silicon HF 20-2000 CHF₃ + O₂ dioxide H₃PO₄:HNO₃: 660 100-150 Aluminum Cl2 + SiCl4 CH₂COOH >4000 35-3500 Photoresist Acetone Gold 40 n/a n/a







